

Notice of References Cited	Application/Control No. 10/726,339	Applicant(s)/Patent Under Reexamination IIDA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0047602	03-2003	Iida et al.	235/382
	B	US-6,070,141	05-2000	Houvener et al.	705/1
	C	US-5,491,471	02-1996	Stobbe, Anatoli	340/5.61
	D	US-5,392,351	02-1995	Hasebe et al.	705/51
	E	US-5,166,676	11-1992	Milheiser, Thomas A.	340/10.34
	F	US-2003/0088520	05-2003	Bohrer et al.	705/74
	G	US-2002/0049907	04-2002	Woods et al.	713/182
	H	US-2002/0023059	02-2002	Bari et al.	705/76
	I	US-2001/0035980	11-2001	Kawabata, Kazuhiro	358/403
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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